


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517674	<b>Applicant(s)/Patent Under Reexamination</b>  HARTLEY ET AL.
	<b>Examiner</b>  Diao, M'baye	<b>Art Unit</b>  2112

SEARCHED			
Class	Subclass	Date	Examiner
320	107,118-119,132-137,146,166	12/19/2006	M.D
429	99-100	12/20/2006	M.D

SEARCH NOTES		
Search Notes	Date	Examiner
East (search notes attached)	12/21/2006	M.D

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner